_	earcn	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/887,676	HEUER, VOLKMAR	
Examiner	Art Unit	
Shick C. Hom	2666	

SEARCHED			
Class	Subclass	Date	Examiner
	updated search	3/11/2006	SH

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		
			-	
			_	
			_	

SEA (INCLUDING	RCH NOT SEARCH S	ES Strategy	)
		DATE	EXMR
East search		3/11/2006	SH